

Appendix C - Calibration

All of the instruments Calibration information are listed below.

- Dipole _ D2450V2 SN: 712 Calibration No.D2450V712_Feb09
- Probe _ ES3DV3 SN:3150 Calibration No.ES3-3150_Apr09
- DAE _ DAE4 SN:541 Calibration No.DAE4-541_ Feb09

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Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Multilateral Agreement for the recognition of calibration certificates

Client ATL (Auden)

Certificate No: D2450V2-712_Feb09

Accreditation No.: SCS 108

CALIBRATION CERTIFICATE

Object

D2450V2 - SN: 712

Calibration procedure(s)

QA CAL-05.v7

Calibration procedure for dipole validation kits

Calibration date:

February 11, 2009

Condition of the calibrated item

In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	08-Oct-08 (No. 217-00898)	Oct-09
Power sensor HP 8481A	US37292783	08-Oct-08 (No. 217-00898)	Oct-09
Reference 20 dB Attenuator	SN: S5086 (20g)	01-Jul-08 (No. 217-00864)	Jul-09
Type-N mismatch combination	SN: 5047.2 / 06327	01-Jul-08 (No. 217-00867)	Jul-09
Reference Probe ES3DV2	SN: 3025	28-Apr-08 (No. ES3-3025_Apr08)	Apr-09
DAE4	SN: 601	14-Mar-08 (No. DAE4-601_Mar08)	Mar-09
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-07)	In house check: Oct-09
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-08)	In house check: Oct-09
	Name	Function	Signature
Calibrated by:	Mike Meili	Laboratory Technician	d'iteil
Approved by:	Katja Pokovic	Technical Manager	100 m

Issued: February 11, 2009

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Certificate No: D2450V2-712_Feb09

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Servizio svizzero di taratui Swiss Calibration Service

Accreditation No.: SCS 108

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Glossary:

TSL tissue simulating liquid

ConvF sensitivity in TSL / NORM x,y,z N/A not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end
 of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed
 point exactly below the center marking of the flat phantom section, with the arms oriented
 parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole
 positioned under the liquid filled phantom. The impedance stated is transformed from the
 measurement at the SMA connector to the feed point. The Return Loss ensures low
 reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point.
 No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	2450 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	39.2	1.80 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	38.0 ± 6 %	1.82 mho/m ± 6 %
Head TSL temperature during test	(22.0 ± 0.2) °C) -	\- <u></u>

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	13.1 mW / g
SAR normalized	normalized to 1W	52.4 mW / g
SAR for nominal Head TSL parameters 1	normalized to 1W	51.8 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	6.13 mW / g
SAR normalized	normalized to 1W	24.5 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	24.3 mW /g ± 16.5 % (k=2)

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¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"



Body TSL parameters

The following parameters and calculations were applied.

The following parameters and a second	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	52.7	1.95 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	$53.9 \pm 6 \%$	2.00 mho/m ± 6 %
Body TSL temperature during test	(21.1 ± 0.2) °C		

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	13.2 mW / g
SAR normalized	normalized to 1W	52.8 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	52.3 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	250 mW input power	6.18 mW / g
SAR normalized	normalized to 1W	24.7 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	24.7 mW /g ± 16.5 % (k=2)

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² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"



Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	55.7 Ω + 1.1 jΩ
Return Loss	- 25.2 dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	50.5 Ω + 5.0 jΩ
Return Loss	- 26.0 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.158 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	July 5, 2002

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DASY5 Validation Report for Head TSL

Date/Time: 04.02.2009 12:44:28

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN712

Communication System: CW; Frequency: 2450 MHz; Duty Cycle: 1:1

Medium: HSL U10 BB

Medium parameters used: f = 2450 MHz; $\sigma = 1.82 \text{ mho/m}$; $\varepsilon_r = 38$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: ES3DV2 - SN3025; ConvF(4.4, 4.4, 4.4); Calibrated: 28.04.2008

Sensor-Surface: 3.4mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 14.03.2008

Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

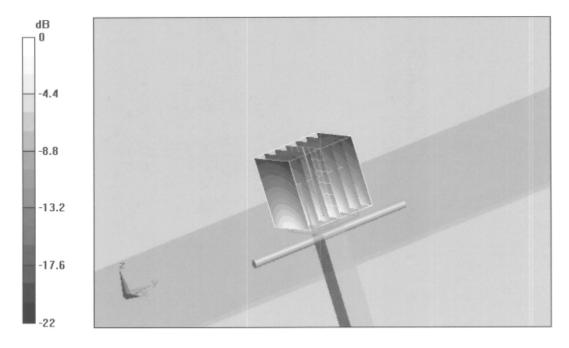
Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0:

Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 95.6 V/m; Power Drift = 0.00522 dB

Peak SAR (extrapolated) = 27.5 W/kg

SAR(1 g) = 13.1 mW/g; SAR(10 g) = 6.13 mW/gMaximum value of SAR (measured) = 15.8 mW/g



0 dB = 15.8 mW/g

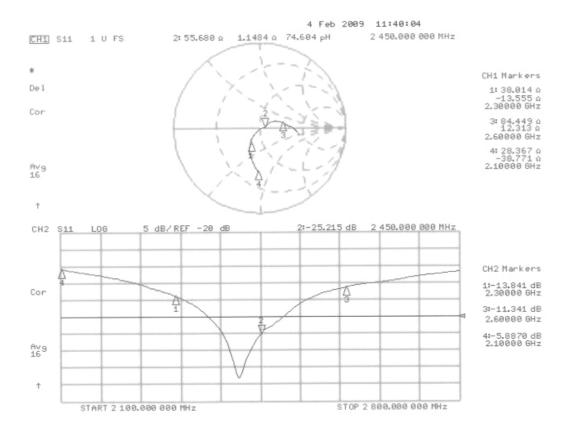
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Impedance Measurement Plot for Head TSL



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Certificate No: D2450V2-712_Feb09



DASY5 Validation Report for Body TSL

Date/Time: 11.02.2009 11:51:07

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN:712

Communication System: CW; Frequency: 2450 MHz; Duty Cycle: 1:1

Medium: MSL U10 BB

Medium parameters used: f = 2450 MHz; $\sigma = 2.01 \text{ mho/m}$; $\varepsilon_r = 54$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: ES3DV2 - SN3025; ConvF(4.07, 4.07, 4.07); Calibrated: 28.04.2008

Sensor-Surface: 3.4mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 14.03.2008

Phantom: Flat Phantom 5.0 (back); Type: QD000P50AA; Serial: 1002

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

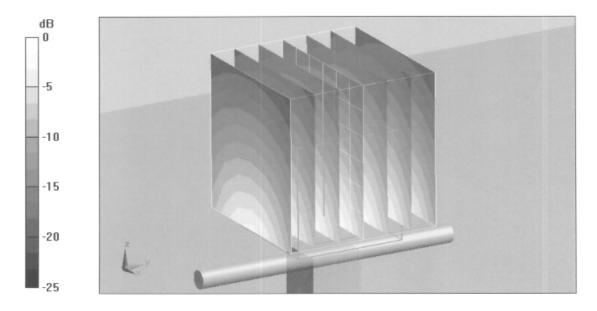
Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0:

Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 92.8 V/m; Power Drift = 0.00271 dB

Peak SAR (extrapolated) = 26.7 W/kg

SAR(1 g) = 13.2 mW/g; SAR(10 g) = 6.18 mW/gMaximum value of SAR (measured) = 16.4 mW/g



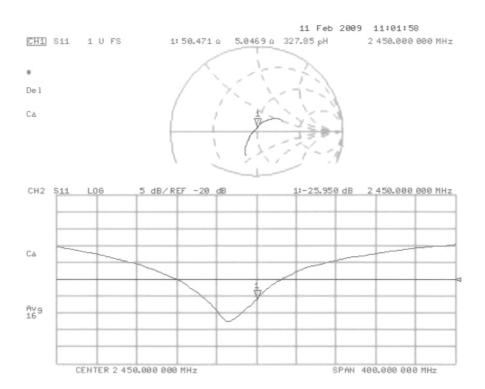
0 dB = 16.4 mW/g

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Impedance Measurement Plot for Body TSL



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Client

ATL (Auden)

Certificate No: ES3-3150_Apr09

Accreditation No.: SCS 108

CALIBRATION CERTIFICATE

Object

ES3DV3 - SN:3150

Calibration procedure(s)

QA CAL-01.v6 and QA CAL-23.v3

Calibration procedure for dosimetric E-field probes

Calibration date:

April 28, 2009 (Additional Conversion Factors)

Condition of the calibrated item

In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

0044000074		
GB41293874	1-Apr-09 (No. 217-01030)	Apr-10
MY41495277	1-Apr-09 (No. 217-01030)	Apr-10
MY41498087	1-Apr-09 (No. 217-01030)	Apr-10
SN: S5054 (3c)	31-Mar-09 (No. 217-01026)	Mar-10
SN: S5086 (20b)	31-Mar-09 (No. 217-01028)	Mar-10
SN: S5129 (30b)	31-Mar-09 (No. 217-01027)	Mar-10
SN: 3013	2-Jan-09 (No. ES3-3013_Jan09)	Jan-10
SN: 660	9-Sep-08 (No. DAE4-660_Sep08)	Sep-09
ID#	Check Date (in house)	Scheduled Check
US3642U01700	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
US37390585	18-Oct-01 (in house check Oct-08)	In house check: Oct-09
Name	Function	Signature
Katja Pokovic	Technical Manager	John Hay
10 1 12 1	Overlite Manager	1/1/2
Niels Kuster	Quality Manager	1/1/20
	MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 3013 SN: 660 ID # US3642U01700 US37390585	MY41498087 1-Apr-09 (No. 217-01030) SN: S5054 (3c) 31-Mar-09 (No. 217-01026) SN: S5086 (20b) 31-Mar-09 (No. 217-01028) SN: S5129 (30b) 31-Mar-09 (No. 217-01027) SN: 3013 2-Jan-09 (No. ES3-3013_Jan09) SN: 660 9-Sep-08 (No. DAE4-660_Sep08) ID# Check Date (in house) US3642U01700 4-Aug-99 (in house check Oct-07) US37390585 18-Oct-01 (in house check Oct-08) Name Function Katja Pokovic Technical Manager

Issued: April 29, 2009

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Glossary:

TSL NORMx,y,z tissue simulating liquid sensitivity in free space

ConvF s DCP d

sensitivity in TSL / NORMx,y,z

DCP Polarization φ diode compression point φ rotation around probe axis

Polarization 9

3 rotation around an axis that is in the plane normal to probe axis (at

measurement center), i.e., θ = 0 is normal to probe axis

Calibration is Performed According to the Following Standards:

 a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003

 b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization θ = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset. The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

Certificate No: ES3-3150_Apr09

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ES3DV3 SN:3150

Probe ES3DV3

SN:3150

Additional Conversion Factors

Manufactured:

June 12, 2007

Last calibrated:

January 20, 2009

Recalibrated:

April 28, 2009

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)



ES3DV3 SN:3150

DASY - Parameters of Probe: ES3DV3 SN:3150

Sensitivity in Free Space^A

Diode Compression^B

April 28, 2009

NormX 1.25 ± 10.1% $\mu V/(V/m)^2$ DCP X 93 mV NormY 1.26 ± 10.1% $\mu V/(V/m)^2$ DCP Y 95 mV NormZ 1.25 ± 10.1% $\mu V/(V/m)^2$ DCP Z 94 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 5.

Sensor Center to Phantom Surface Distance 3.0 mm 4.0 mm SAR_{be} [%] Without Correction Algorithm 11.0 6.8 SAR_{be} [%] With Correction Algorithm 0.8 0.5

TSL

1900 MHz

Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance		3.0 mm	4.0 mm
SAR _{be} [%]	Without Correction Algorithm	11.8	8.0
SAR _{be} [%]	With Correction Algorithm	0.9	0.6

Sensor Offset

Probe Tip to Sensor Center

2.0 mm

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: ES3-3150_Apr09

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A The uncertainties of NormX,Y,Z do not affect the E2-field uncertainty inside TSL (see Page 8).

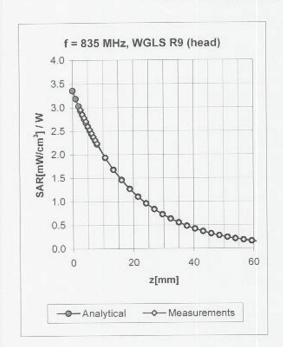
^a Numerical linearization parameter: uncertainty not required.

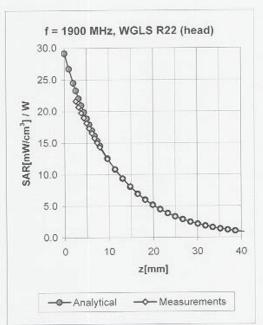


ES3DV3 SN:3150

April 28, 2009

Conversion Factor Assessment





f [MHz]	Validity [MHz] ^C	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	0.59	1.41	6.05 ± 11.0% (k=2)
1900	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.38	2.11	5.12 ± 11.0% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	0.99	1.13	6.02 ± 11.0% (k=2)
1900	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.41	2.15	4.81 ± 11.0% (k=2)

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 $^{^{\}circ}$ The validity of \pm 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.



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Client

ATL (Auden)

Certificate No: DAE4-541_Feb09

Accreditation No.: SCS 108

CALIBRATION CERTIFICATE

Object

DAE4 - SD 000 D04 BJ - SN: 541

Calibration procedure(s)

QA CAL-06.v12

Calibration procedure for the data acquisition electronics (DAE)

Calibration date:

February 10, 2009

Condition of the calibrated item

In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	30-Sep-08 (No: 7673)	Sep-09
Keithley Multimeter Type 2001	SN: 0810278	30-Sep-08 (No: 7670)	Sep-09
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	06-Jun-08 (in house check)	In house check: Jun-09

Calibrated by:

Name Daniel Hess Function Technician Signature

Approved by:

Fin Bomholt

R&D Director

Issued: February 10, 2009

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Certificate No: DAE4-541_Feb09

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Glossarv

DAE

data acquisition electronics

Connector angle

information used in DASY system to align probe sensor X to the robot

coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

Certificate No: DAE4-541_Feb09

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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB =

 $6.1 \mu V$, 61nV,

full range = -100...+300 mV full range = -1......+3mV

Low Range:

1LSB =

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	Х	Υ	Z
High Range	404.590 ± 0.1% (k=2)	404.475 ± 0.1% (k=2)	404.230 ± 0.1% (k=2)
Low Range	3.96369 ± 0.7% (k=2)	3.95198 ± 0.7% (k=2)	3.96911 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	290 ° ± 1 °



Appendix

1. DC Voltage Linearity

High Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	200000	200000	0.00
Channel X + Input	20000	20006.58	0.03
Channel X - Input	20000	-19998.29	-0.01
Channel Y + Input	200000	200000.1	0.00
Channel Y + Input	20000	20000.17	0.00
Channel Y - Input	20000	-20003.10	0.02
Channel Z + Input	200000	200000.1	0.00
Channel Z + Input	20000	20004.44	0.02
Channel Z - Input	20000	-19998.76	-0.01

Low Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	2000	2000.1	0.00
Channel X	+ Input	200	199.81	-0.09
Channel X	- Input	200	-200.41	0.20
Channel Y	+ Input	2000	2000.1	0.00
Channel Y	+ Input	200	199.52	-0.24
Channel Y	- Input	200	-200.54	0.27
Channel Z	+ Input	2000	2000.1	0.00
Channel Z	+ Input	200	199.17	-0.42
Channel Z	- Input	200	-201.07	0.53

2. Common mode sensitivity

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3. Sec; Measuring time: 3 sec; Measuring time: 3

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	11.35	10.66
	- 200	-10.12	-10.20
Channel Y	200	1.63	1.34
	- 200	-2.00	-2.45
Channel Z	200	1.36	0.91
	- 200	-1.75	-2.09

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	3.55	-0.09
Channel Y	200	0.32	-	5.22
Channel Z	200	-0.36	0.33	(2~

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15992	15779
Channel Y	15779	15842
Channel Z	15970	16928

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	-0.06	-0.79	0.84	0.26
Channel Y	-0.72	-1.57	0.26	0.32
Channel Z	-0.95	-2.45	0.17	0.33

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2000	198.8
Channel Y	0.2000	202.2
Channel Z	0.2000	202.5

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9

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